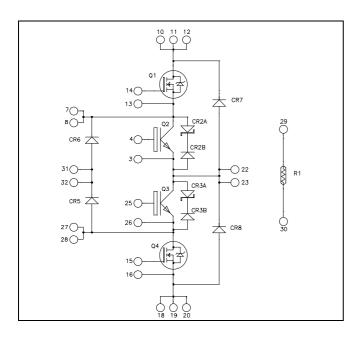
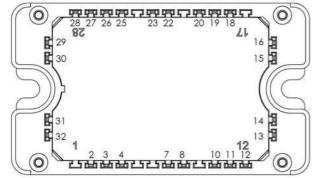


## Three level inverter Power Module





All multiple inputs and outputs must be shorted together Example: 10/11/12; 7/8 ...

## Trench & Field Stop IGBT4 Q2, Q3:

 $V_{CES} = 1200V$ ;  $I_C = 40A$  @  $Tc = 80^{\circ}C$ 

#### Super junction MOSFET Q1, Q4: $V_{DSS} = 900V$ ; $I_D = 23A$ @ Tc = 80°C

#### Application

- Solar converter
- Uninterruptible Power Supplies

#### Features

- Q2, Q3 Trench + Field Stop IGBT 4
- Low voltage drop
- Low leakage current
- Low switching losses
- Q1, Q4 Super junction MOSFET
- Ultra low R<sub>DSon</sub>
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated
- Very rugged
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

#### Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



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#### Q1 & Q4 Absolute maximum ratings (per Super junction MOSFET)

| Symbol            | Parameter   | ·                   | Max ratings | Unit |
|-------------------|---|---------------------|-------------|------|
| V <sub>DSS</sub>  | Drain - Source Voltage                            |                     | 900         | V    |
| т                 | Continuous Dusin Cumont                           | $T_c = 25^{\circ}C$ | 30          |      |
| I <sub>D</sub>    | Continuous Drain Current                          | $T_c = 80^{\circ}C$ | 23          | А    |
| I <sub>DM</sub>   | Pulsed Drain current                              |                     | 75          |      |
| V <sub>GS</sub>   | Gate - Source Voltage                             |                     | ±20         | V    |
| R <sub>DSon</sub> | Drain - Source ON Resistance                      |                     | 120         | mΩ   |
| PD                | Power Dissipation                                 | $T_c = 25^{\circ}C$ | 250         | W    |
| I <sub>AR</sub>   | Avalanche current (repetitive and non repetitive) |                     | 8.8         | Α    |
| EAR               | Repetitive Avalanche Energy                       |                     | 2.9         | mI   |
| E <sub>AS</sub>   | Single Pulse Avalanche Energy                     |                     | 1940        | mJ   |

### Q1 & Q4 Electrical Characteristics (per Super junction MOSFET)

| Symbol              | Characteristic                  | Test Conditions                  | Min | Тур | Max | Unit |
|---------------------|---------------------------------|----------------------------------|-----|-----|-----|------|
| I <sub>DSS</sub>    | Zero Gate Voltage Drain Current | $V_{GS} = 0V, V_{DS} = 900V$     |     |     | 100 | μA   |
| R <sub>DS(on)</sub> | Drain – Source on Resistance    | $V_{GS} = 10V, I_D = 26A$        |     | 100 | 120 | mΩ   |
| V <sub>GS(th)</sub> | Gate Threshold Voltage          | $V_{GS} = V_{DS}, I_D = 3mA$     | 2.5 | 3   | 3.5 | V    |
| I <sub>GSS</sub>    | Gate – Source Leakage Current   | $V_{GS} = \pm 20 V, V_{DS} = 0V$ |     |     | 100 | nA   |

### Q1 & Q4 Dynamic Characteristics (per Super junction MOSFET)

| Symbol              | Characteristic                      | Test Conditions                 | Min | Тур  | Max | Unit |
|---------------------|-------------------------------------|---------------------------------|-----|------|-----|------|
| C <sub>iss</sub>    | Input Capacitance                   | $V_{GS} = 0V$ ; $V_{DS} = 100V$ |     | 6800 |     | pF   |
| Coss                | Output Capacitance                  | f = 1MHz                        |     | 330  |     | pr   |
| Qg                  | Total gate Charge                   | $V_{GS} = 10V$                  |     | 270  |     |      |
| $Q_{gs}$            | Gate – Source Charge                | $V_{Bus} = 400 V$               |     | 32   |     | nC   |
| $Q_{gd}$            | Gate – Drain Charge                 | $I_D = 26A$                     |     | 115  |     |      |
| T <sub>d(on)</sub>  | Turn-on Delay Time                  | Inductive Switching (125°C)     |     | 70   |     |      |
| Tr                  | Rise Time                           | $V_{GS} = 10V$                  |     | 20   |     |      |
| T <sub>d(off)</sub> | Turn-off Delay Time                 | $V_{Bus} = 400V$<br>$I_D = 26A$ |     | 400  |     | ns   |
| $T_{\mathrm{f}}$    | Fall Time                           | $R_G = 7.5\Omega$               |     | 25   |     |      |
| $R_{thJC}$          | Junction to Case Thermal resistance |                                 |     |      | 0.5 | °C/W |

### Q2 & Q3 Absolute maximum ratings (per IGBT)

| Symbol           | Parameter                        |                      | Max ratings | Unit |
|------------------|----------------------------------|----------------------|-------------|------|
| V <sub>CES</sub> | Collector - Emitter Voltage      |                      | 1200        | V    |
| т                | Continuous Collector Current     | $T_C = 25^{\circ}C$  | 60          |      |
| I <sub>C</sub>   | Continuous Conector Current      | $T_C = 80^{\circ}C$  | 40          | Α    |
| I <sub>CM</sub>  | Pulsed Collector Current         | $T_C = 25^{\circ}C$  | 70          |      |
| V <sub>GE</sub>  | Gate – Emitter Voltage           |                      | ±20         | V    |
| PD               | Power Dissipation                | $T_C = 25^{\circ}C$  | 220         | W    |
| RBSOA            | Reverse Bias Safe Operating Area | $T_j = 150^{\circ}C$ | 70A @ 1100V |      |



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### Q2 & Q3 Electrical Characteristics (per IGBT)

| Symbol               | Characteristic                       | Test Conditions                        |                      | Min | Тур  | Max  | Unit |
|----------------------|--------------------------------------|--|----------------------|-----|------|------|------|
| I <sub>CES</sub>     | Zero Gate Voltage Collector Current  | $V_{GE} = 0V, V_{CE} = 1200V$          |                      |     |      | 250  | μΑ   |
| V                    | Collector Emitter extinction Voltage | $V_{GE} = 15V$                         | $T_j = 25^{\circ}C$  |     | 1.85 | 2.25 | V    |
| V <sub>CE(sat)</sub> | Collector Emitter saturation Voltage | $I_C = 35A$                            | $T_j = 150^{\circ}C$ |     | 2.25 |      | v    |
| V <sub>GE(th)</sub>  | Gate Threshold Voltage               | $V_{GE} = V_{CE}, I_C = 1.2 \text{mA}$ |                      | 5.0 | 5.8  | 6.5  | V    |
| I <sub>GES</sub>     | Gate – Emitter Leakage Current       | $V_{GE} = 20V, V_{CE}$                 | = 0V                 |     |      | 400  | nA   |

### Q2 & Q3 Dynamic Characteristics (per IGBT)

| Symbol              | Characteristic                      | Test Conditions   | i da se | Min | Тур  | Max  | Unit |
|---------------------|-------------------------------------|---|---|-----|------|------|------|
| Cies                | Input Capacitance                   | $V_{GE} = 0V$   |   |     | 1950 |      |      |
| Coes                | Output Capacitance                  | $V_{CE} = 25V$  |   |     | 155  |      | pF   |
| Cres                | Reverse Transfer Capacitance        | f = 1 MHz   |   |     | 115  |      |      |
| $Q_{G}$             | Gate charge                         | $V_{GE} = \pm 15V$ ; $V_{GE} = 35A$   | <sub>CE</sub> =600V                         |     | 0.27 |      | μC   |
| T <sub>d(on)</sub>  | Turn-on Delay Time                  | Inductive Switch  | hing (25°C)                                 |     | 130  |      |      |
| Tr                  | Rise Time                           | $V_{GE} = \pm 15V$  |   |     | 20   |      |      |
| T <sub>d(off)</sub> | Turn-off Delay Time                 | $V_{CE} = 600V$<br>$I_{C} = 35A$  |   |     | 300  |      | ns   |
| $T_{\rm f}$         | Fall Time                           | $R_G = 12\Omega$  |   |     | 45   |      |      |
| T <sub>d(on)</sub>  | Turn-on Delay Time                  | Inductive Switching (150°C)   |   |     | 150  |      |      |
| Tr                  | Rise Time                           | $V_{GE} = \pm 15V$ $V_{CE} = 600V$  |   |     | 35   |      | ns   |
| T <sub>d(off)</sub> | Turn-off Delay Time                 | $I_C = 35A$   |   |     | 350  |      | 115  |
| $T_{\rm f}$         | Fall Time                           | $R_G = 12\Omega$  |   |     | 80   |      |      |
| Eon                 | Turn-on Switching Energy            | $V_{GE} = \pm 15 V$   | $T_J = 25^{\circ}C$                         |     | 2.6  |      | mJ   |
| Lon                 | Turn-on Switching Energy            | $V_{CE} = 600V$   | $T_J = 150^{\circ}C$                        |     | 4    |      | IIIJ |
| E <sub>off</sub>    | Turn-off Switching Energy           | $I_C = 35A$   | $T_J = 25^{\circ}C$                         |     | 2    |      | mJ   |
| Lott                | Turn on Switching Lifergy           | $R_G = 12\Omega$  | $T_J = 150^{\circ}C$                        |     | 3    |      | 1115 |
| $I_{sc}$            | Short Circuit data                  | $ \begin{array}{l} V_{GE} \leq \!\! 15 V \; ; \; V_{Bus} = 900 V \\ t_p \! \leq \!\! 10 \mu s \; ; \; T_j = 150^\circ C \end{array} $ |   |     | 140  |      | А    |
| $R_{thJC}$          | Junction to Case Thermal Resistance |   |   |     |      | 0.68 | °C/W |

### CR2 & CR3 diode ratings and characteristics (per device)

| Symbol            | Characteristic                      | Test Conditions | Min | Тур  | Max | Unit |
|-------------------|-------------------------------------|-----------------|-----|------|-----|------|
| $V_{\rm F}$       | Diode + tranzorb Forward Voltage    | $I_F = 10A$     |     | 10.5 |     | V    |
| R <sub>thJC</sub> | Junction to Case Thermal Resistance |                 |     |      | 8   | °C/W |



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#### CR5 & CR6 diode ratings and characteristics (per diode)

| Symbol            | Characteristic                      | Test Conditions                                |                               | Min | Тур  | Max  | Unit |
|-------------------|-------------------------------------|--|-------------------------------|-----|------|------|------|
| V <sub>RRM</sub>  | Peak Repetitive Reverse Voltage     |  |                               |     |      | 1000 | V    |
| I <sub>RM</sub>   | Reverse Leakage Current             | V <sub>R</sub> =1000V                          |                               |     |      | 100  | μA   |
| I <sub>F</sub>    | DC Forward Current                  |  | $Tc = 80^{\circ}C$            |     | 40   |      | Α    |
|                   |                                     | $I_F = 40A$                                    |                               |     | 2.5  | 3    |      |
| $V_{\rm F}$       | Diode Forward Voltage               | $I_F = 80A$                                    |                               |     | 3.1  |      | v    |
|                   |                                     | $I_F = 40A$                                    | $T_j = 125^{\circ}C$          |     | 2    |      | v    |
| +                 | Reverse Recovery Time               |  | $T_j = 25^{\circ}C$           |     | 250  |      | 20   |
| t <sub>rr</sub>   | Reverse Recovery Time               | $I_F = 40A$                                    | $T_j = 125^{\circ}C$          |     | 315  |      | ns   |
| 0                 | Reverse Recovery Charge             | $V_R = 667V$<br>di/dt = 200A/µs                | $T_j = 25^{\circ}C$           |     | 415  |      | nC   |
| Q <sub>rr</sub>   | Reverse Recovery Charge             |  | $T_j = 125^{\circ}C$          |     | 1650 |      | ne   |
| Err               | Reverse Recovery Energy             | $I_F = 40A$ $V_R = 667V$ $di/dt = 1000A/\mu s$ | $T_j = 125^{\circ}\mathrm{C}$ |     | 1.3  |      | mJ   |
| R <sub>thJC</sub> | Junction to Case Thermal Resistance |  |                               |     |      | 1.2  | °C/W |

### CR7 & CR8 diode ratings and characteristics (per diode)

| Symbol           | Characteristic                      | Test Conditions                                |                      | Min                  | Тур  | Max  | Unit |   |
|------------------|-------------------------------------|--|----------------------|----------------------|------|------|------|---|
| V <sub>RRM</sub> | Peak Repetitive Reverse Voltage     |  |                      |                      |      | 1200 | V    |   |
| I <sub>RM</sub>  | Reverse Leakage Current             | V <sub>R</sub> =1200V                          |                      |                      |      | 100  | μΑ   |   |
| I <sub>F</sub>   | DC Forward Current                  |  | $Tc = 80^{\circ}C$   |                      | 40   |      | Α    |   |
|                  |                                     | $I_F = 30A$                                    |                      |                      | 2.6  | 3.1  |      |   |
| $V_{\rm F}$      | Diode Forward Voltage               | $I_F = 60A$                                    |                      |                      | 3.2  |      | v    |   |
|                  |                                     | $I_F = 30A$                                    | $I_F = 30A$          | $T_j = 125^{\circ}C$ |      | 1.8  |      | v |
| +                | Povora Popovoru Timo                |  | $T_j = 25^{\circ}C$  |                      | 300  |      |      |   |
| t <sub>rr</sub>  | Reverse Recovery Time               | $I_F = 30A$                                    | $T_j = 125^{\circ}C$ |                      | 380  |      | ns   |   |
| 0                | Reverse Recovery Charge             | $V_R = 800V$<br>di/dt = 200A/us                | $T_j = 25^{\circ}C$  |                      | 360  |      | nC   |   |
| Q <sub>rr</sub>  | Reverse Recovery Charge             |  | $T_j = 125^{\circ}C$ |                      | 1700 |      | ne   |   |
| E <sub>rr</sub>  | Reverse Recovery Energy             | $I_F = 30A$ $V_R = 800V$ $di/dt = 1000A/\mu s$ | $T_j = 125^{\circ}C$ |                      | 1.6  |      | mJ   |   |
| $R_{thJC}$       | Junction to Case Thermal Resistance |  |                      |                      |      | 1.2  | °C/W |   |

#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

| Symbol                 | Characteristic              |                       | Min | Тур  | Max | Unit |
|------------------------|-----------------------------|-----------------------|-----|------|-----|------|
| R <sub>25</sub>        | Resistance @ 25°C           | @ 25°C                |     | 50   |     | kΩ   |
| $\Delta R_{25}/R_{25}$ |                             |                       |     | 5    |     | %    |
| B <sub>25/85</sub>     | $T_{25} = 298.15 \text{ K}$ |                       |     | 3952 |     | Κ    |
| $\Delta B/B$           |                             | T <sub>C</sub> =100°C |     | 4    |     | %    |
|                        |                             |                       |     |      |     |      |

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

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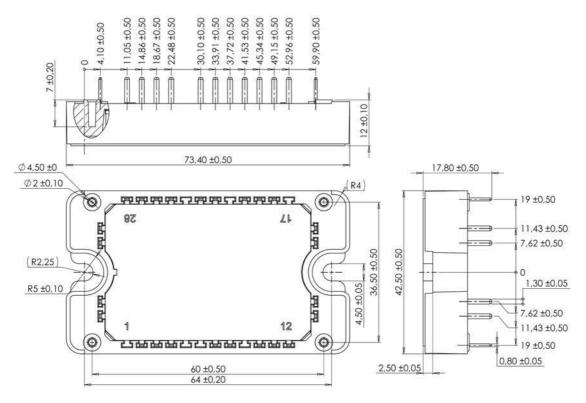
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### Thermal and package characteristics

| Symbol           | Characteristic  |                 |      | Min  | Max                    | Unit |
|------------------|---|-----------------|------|------|------------------------|------|
| VISOL            | RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz |                 |      | 4000 |                        | V    |
| TJ               | Operating junction temperature range                          |                 |      | -40  | 175*                   |      |
| T <sub>JOP</sub> | Recommended junction temperature under s                      | witching condit | ions | -40  | T <sub>J</sub> max -25 | °C   |
| T <sub>STG</sub> | Storage Temperature Range                                     |                 |      | -40  | 125                    | C    |
| T <sub>C</sub>   | Operating Case Temperature                                    |                 |      | -40  | 125                    |      |
| Torque           | Mounting torque   | To heatsink     | M4   | 2    | 3                      | N.m  |
| Wt               | Package Weight  |                 |      |      | 110                    | g    |

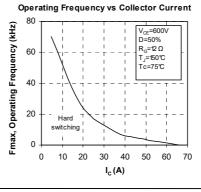
\* Tjmax = 150°C for Q1 & Q4

#### Package outline (dimensions in mm)

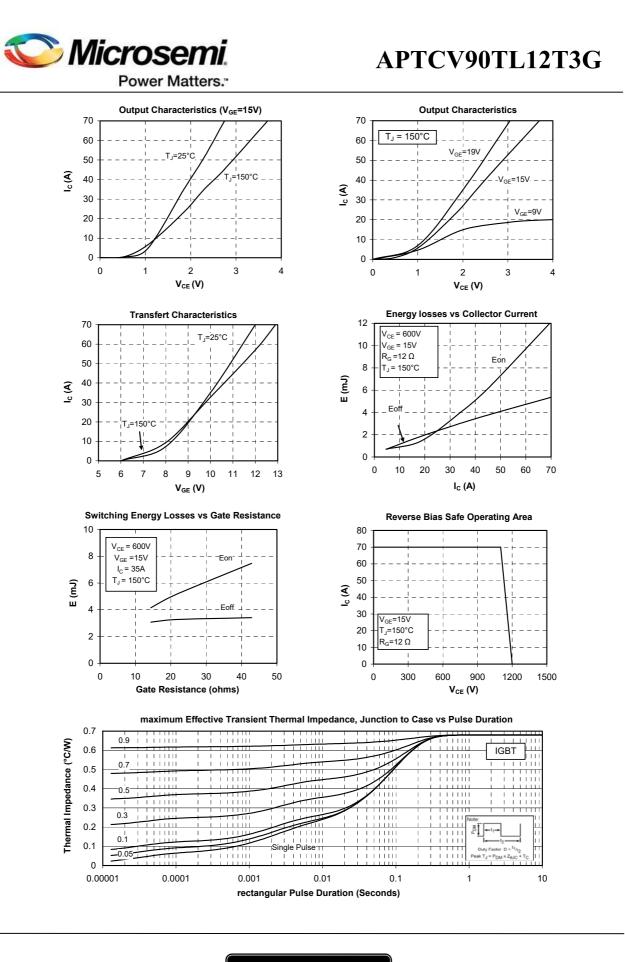


See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

#### Q2 & Q3 Typical performance curve



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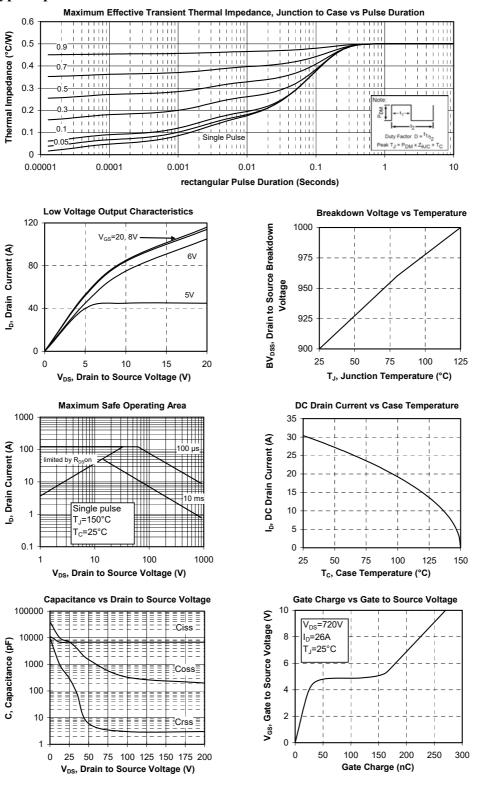
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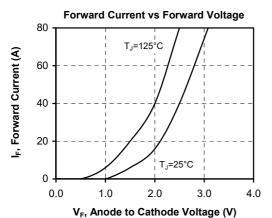


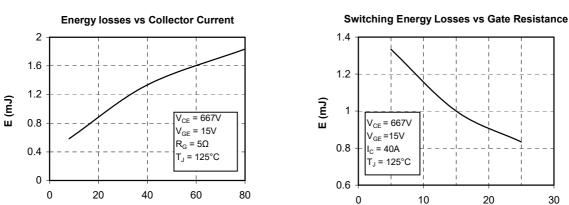
#### Q1 & Q4 Typical performance curve



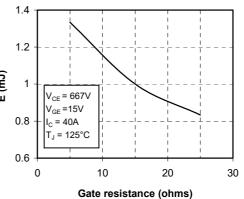


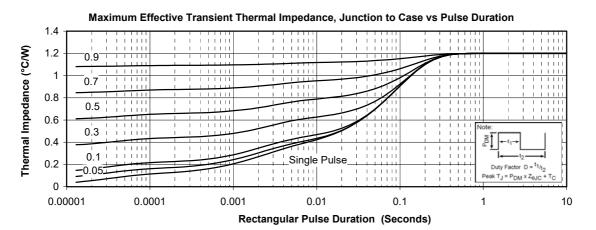




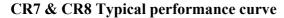


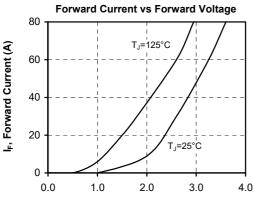
I<sub>c</sub> (A)



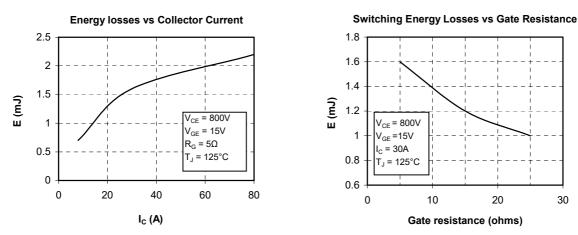


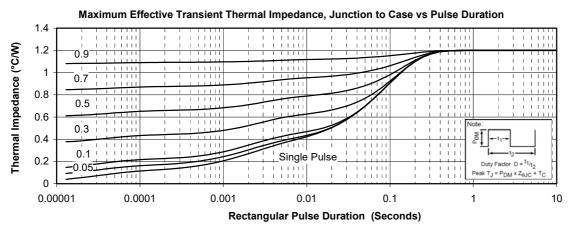






V<sub>F</sub>, Anode to Cathode Voltage (V)







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